Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | HAYASHI ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0229183 A1	12-2003	Voorheis et al.	525/232
	В	US-2003/0114246 A1	06-2003	Yokota, Masatoshi	473/351
	С	US-4,955,613	09-1990	Gendreau et al.	473/372
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-	8		
	К	US-			•
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

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